

# MX27C8100

# 8M-BIT(1M x 8/512K x 16) CMOS EPROM

### **FEATURES**

- 1M x 8 or 512K x 16 organization
- +12.5V programming voltage
- Fast access time: 120/150/175/200 ns
- · Totally static operation
- · Completely TTL compatible

- · Operating current: 60mA
- Standby current: 100μA
- · Package type:
  - 42 pin ceramic DIP
  - 42 pin plastic DIP
  - 44 pin SOP

## **GENERAL DESCRIPTION**

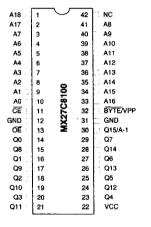
The MX27C8100 is a 5V only, 8M-bit, ultraviolet Erasable Programmable Read Only Memory. It is organized as 1M x 8 or 512K x 16, operates from a single + 5 volt supply, has a static standby mode, and features fast single address location programming. All programming signals are TTL levels, requiring a single pulse. For programming outside from the system, existing EPROM programmers may be used. The MX27C8100 supports a intelligent

quick pulse programming algorithm which can result in programming times of less than two minutes.

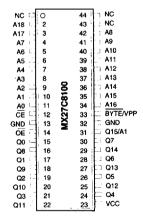
This EPROM is packaged in industry standard 42 pin dual-in-line ceramic packages or 42 pin plastic packages, and 44 pin SOP package.

## **PIN CONFIGURATIONS**

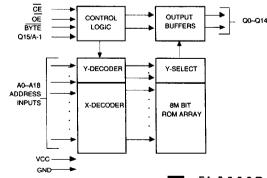
### PDIP/CDIP



## SOP



## **BLOCK DIAGRAM**



5688882 0000957 069 1



# PIN DESCRIPTION

SYMBOL	PIN NAME
A0~A18	Address Input
Q0~Q14	Data Input/Output
CE	Chip Enable Input
OE .	Output Enable Input
BYTE/VPP	Word/Byte Selection
	/Program Supply Voltage
Q15/A-1	Q15(Word mode)/LSB addr. (Byte mode)
VCC	Power Supply Pin (+5V)
GND	Ground Pin

# TRUTH TABLE OF BYTE FUNCTION

# BYTE MODE(BYTE = GND)

CE	OE/OE	D15/A-1	MODE	D0-D7	SUPPLY CURRENT	NOTE
н	x	. X	Non selected	High Z	Standby(ICC2)	1
L	L/H	x	Non selected	High Z	Operating(ICC1)	4 <b>1</b> 4
L	H/L	A-1 input	Selected	DOUT	Operating(ICC1)	1

# WORD MODE( $\overline{BYTE} = VCC$ )

CE	OE/OE	D15/A-1	MODE	D0-D14	SUPPLY CURRENT	NOTE
Н	X	High Z	Non selected	High Z	Standby(ICC2)	1
L	L/H	High Z	Non selected	High Z	Operating(ICC1)	1
L	H/L	DOUT	Selected	DOUT	Operating(ICC1)	1

NOTE1: X = H or L



### **FUNCTIONAL DESCRIPTION**

## THE ERASURE OF THE MX27C8100

The MX27C8100 is erased by exposing the chip to an ultraviolet light source. A dosage of 15 W seconds/cm² is required to completely erase a MX27C8100. This dosage can be obtained by exposure to an ultraviolet lamp — wavelength of 2537 Angstroms (Å) — with intensity of 12,000  $\mu\text{W/cm}^2$  for 15 to 20 minutes. The MX27C8100 should be directly under and about one inch from the source and all filters should be removed from the UV light source prior to erasure.

It is important to note that the MX27C8100, and similar devices, will be cleared for all bits of their programmed states with light sources having wavelengths shorter than 4000 Å. Although erasure times will be much longer than that with UV sources at 2537Å, nevertheless the exposure to fluorescent light and sunlight will eventually erase the MX27C8100 and exposure to them should be prevented to realize maximum system reliability. If used in such an environment, the package window should be covered by an opaque label or substance.

### THE PROGRAMMING OF THE MX27C8100

When the MX27C8100 is delivered, or it is erased, the chip has all 8M bits in the "ONE", or HIGH state. "ZEROs" are loaded into the MX27C8100 through the procedure of programming.

The programming mode is entered when 12.5  $\pm$  5V is applied to the BYTE/VPP pin, OE at VIH and CE at VIL .

For programming, the data to be programmed is applied with 16 bits in parallel to the data pins.

The flowchart in Figure 1 shows MXIC's interactive algorithm. Interactive algorithm reduces programming time by using short programming pulses and giving each address only as many pulses as is necessary in order to reliably program the data. After each pulse is applied to a given address, the data in that address is verified. If the data is not verified, additional pulses are given until it is verified or the maximum is reached. This process is repeated while sequencing through each address of the MX27C8100. This part of the algorithm is done at VCC = 6.0V to assure that each EPROM bit is programmed to a sufficiently high threshold voltage. After the interactive programming is completed, an overprogram pulse is

given to each memory location; this ensures that all bits have sufficient margin. After the final address is completed, the entire EPROM memory is verified at VCC =  $5V \pm 10\%$ .

### **FAST PROGRAMMING**

The device is set up in the fast programming mode when the programming voltage VPP = 12.75V is applied, with VCC = 6.25 V and  $\overrightarrow{OE}$  = VIH (Algorithm is shown in Figure 2). The programming is achieved by applying a single TTL low level 100µs pulse to the  $\overrightarrow{CE}$  input after addresses and data line are stable. If the data is not verified, an additional pulse is applied for a maximum of 25 pulses. This process is repeated while sequencing through each address of the device. When the programming mode is completed, the data in all address is verified at VCC = VPP = 5V  $\pm$  10%.

### **PROGRAM INHIBIT MODE**

Programming of multiple MX27C8100's in parallel with different data is also easily accomplished by using the Program Inhibit Mode. Except for CE and OE, all like inputs of the parallel MX27C8100 may be common. A TTL low-level program pulse applied to an MX27C8100  $\overline{\text{CE}}$  input with VPP = 12.5  $\pm$  0.5 V will program the MX27C8100. A high-level  $\overline{\text{CE}}$  input inhibits the other MX27C8100 from being programmed.

## **PROGRAM VERIFY MODE**

Verification should be performed on the programmed bits to determine that they were correctly programmed. The verification should be performed with  $\overline{OE}$  and  $\overline{CE}$ , at VIL, and VPP at its programming voltage.

## **AUTO IDENTIFY MODE**

The auto identify mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and device type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional in the 25°C  $\pm$ 5°C ambient temperature range that is required when programming the MX27C8100.



To activate this mode, the programming equipment must force  $12.0\pm0.5$  V on address line A9 of the device. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from VIL to VIH. All other address lines must be held at VIL during auto identify mode.

Byte 0 (A0 = VIL) represents the manufacturer code, and byte 1 (A0 = VIH), the device identifier code. For the MX27C8100, these two identifier bytes are given in the Mode Select Table. All identifiers for manufacturer and device codes will possess odd parity, with the MSB (DQ15) defined as the parity bit.

#### READ MODE

The MX27C8100 has two control functions, both of which must be logically satisfied in order to obtain data at the outputs. Chip Enable (CE) is the power control and should be used for device selection. Output Enable (OE) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that addresses are stable, address access time (tACC) is equal to the delay from CE to output (tCE). Data is available at the outputs tOE after the falling edge of OE's, assuming that CE has been LOW and addresses have been stable for at least tACC - t OE.

## WORD-WIDE MODE

With BYTE/VPP at VCC ± 0.2V outputs Q0-7 present data D0-7 and outputs Q8-15 present data D8-15, after CE and OE are appropriately enabled.

## BYTE-WIDE MODE

With BYTE/VPP at GND  $\pm$  0.2V, outputs Q8-15 are tristated. If Q15/A-1 = VIH, outputs Q0-7 present data bits D8-15. If Q15/A-1 = VIL, outputs Q0-7 present data bits D0-7.

## STANDBY MODE

The MX27C8100 has a CMOS standby mode which reduces the maximum VCC current to 100  $\mu$ A. It is placed in CMOS standby when CE is at VCC  $\pm$  0.3 V. The

MX27C8100 also has a TTL-standby mode which reduces the maximum VCC current to 1.5 mA. It is placed in TTL-standby when CE is at VIH. When in standby mode, the outputs are in a high-impedance state, independent of the OE input.

#### TWO-LINE OUTPUT CONTROL FUNCTION

To accommodate multiple memory connections, a twoline control function is provided to allow for:

- 1. Low memory power dissipation.
- 2. Assurance that output bus contention will not occur.

It is recommended that CE be decoded and used as the primary device-selecting function, while OE be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low-power standby mode and that the output pins are only active when data is desired from a particular memory device.

#### SYSTEM CONSIDERATIONS

During the switch between active and standby conditions, transient current peaks are produced on the rising and falling edges of Chip Enable. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. At a minimum, a 0.1  $\mu\text{F}$  ceramic capacitor (high frequency, low inherent inductance) should be used on each device between Vcc and GND to minimize transient effects. In addition, to overcome the voltage drop caused by the inductive effects of the printed circuit board traces on EPROM arrays, a 4.7  $\mu\text{F}$  bulk electrolytic capacitor should be used between VCC and GND for each eight devices. The location of the capacitor should be close to where the power supply is connected to the array.



# **MODE SELECT TABLE**

		_	_				BYTE/		
MODE	NOTES	CE	OE	A9	A0	Q15/A-1	VPP(4)	Q8-14	Q0-7
Read (Word)	1	VIL	VIL	x	x	D15 Out	VCC	D8-14 Out	D0-7 Out
Read (Upper Byte)		VIL	VIL	Х	Х	VIH	GND	High Z	D8-15 Out
Read (Lower Byte)		VIL	VIL	X	х	VIL	GND	High Z	D0-7 Out
Output Disable		VIL	VIH	Х	Х	High Z	Х	High Z	High Z
Standby		VIH	X	X	х	High Z	Х	High Z	High Z
Program	2	VIL	VIH	х	х	D15 In	VPP	D8-14 In	D0-7 In
Program Verify		VIH	VIL	Х	Х	D15 Out	VPP	D8-14 Out	D0-7 Out
Program Inhibit		VIH	VIH	х	X	High Z	VPP	Hìgh Z	High Z
Manufacturer Code	2,3,5	VIL	VIL	VH	VIL	ОВ	vcc	00H	C2H
Device Code	5	VIL	VIL	VH	VIH	1B	VCC	38H	16H

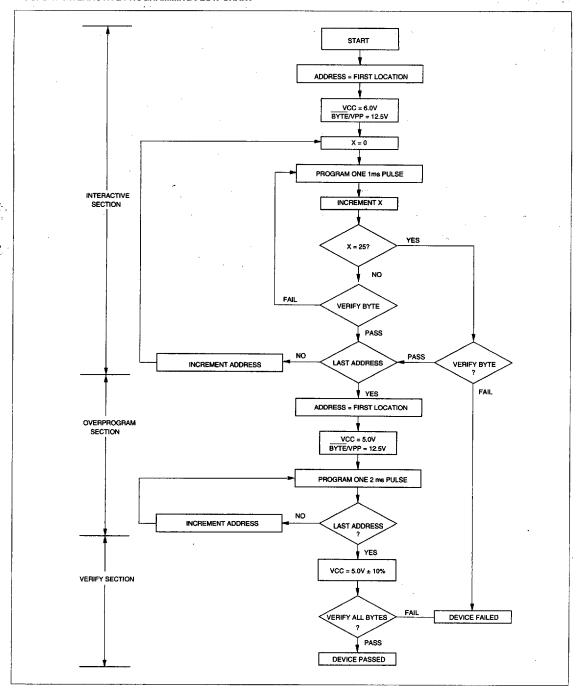
NOTES: 1. X can be VIL or VIH.

2. See DC Programming Characteristics for VPP voltages.

- 3. A1 A8, A10 A15 = VIL , A9 = VH =  $12.0V \pm 0.5V$
- BYTE/VPP is intended for operation under DC Voltage conditions only.
- 5. Manufacture code = 00C2H Device code = B816H

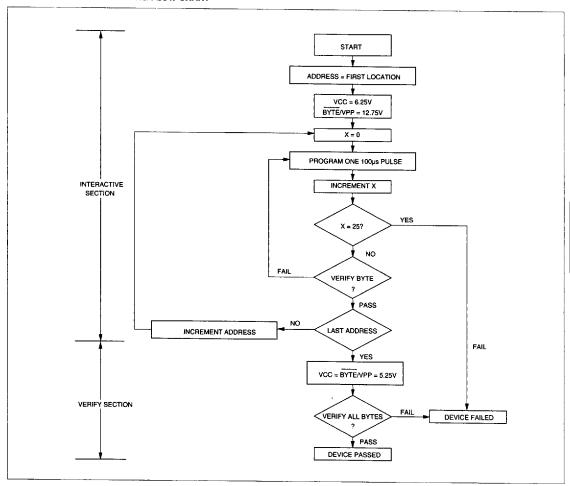


FIGURE 1. INTERACTIVE PROGRAMMING FLOW CHART



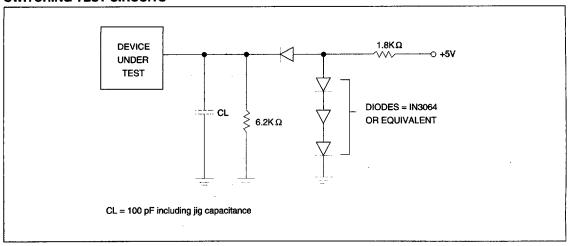


## FIGURE 2. FAST PROGRAMMING FLOW CHART

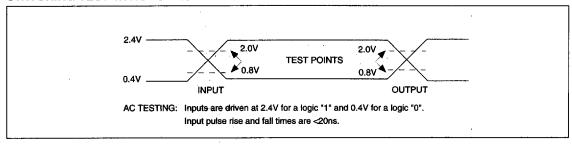




## **SWITCHING TEST CIRCUITS**



## **SWITCHING TEST WAVEFORMS**





## **ABSOLUTE MAXIMUM RATINGS**

RATING	VALUE
Ambient Operating Temperature	0°C to 70°C
Storage Temperature	-65°C to 125°C
Applied Input Voltage	-0.5V to 7.0V
Applied Output Voltage	-0.5V to VCC + 0.5V
VCC to Ground Potential	-0.5V to 7.0V
A9 & VPP	-0.5V to 13.5V

### NOTICE:

Stresses greater than those listed under ABSOLUTE MAXIMUM RAT-INGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended period may affect reliability.

### NOTICE:

Specifications contained within the following tables are subject to change.

# **DC CHARACTERISTICS** TA = $0^{\circ}$ C to $70^{\circ}$ C, VCC = 5V $\pm$ $10^{\circ}$ K

SYMBOL	PARAMETER	MIN.	MAX. L	JNIT	CONDITIONS
VOH	Output High Voltage	2.4		V	IOH = -0.4mA
VOL	Output Low Voltage		0.4	V	IOL = 2.1mA
VIH	Input High Voltage	2.0	VCC + 0.5	5 V	
VIL	Input Low Voltage	-0.3	0.8	٧	
ILI	Input Leakage Current	-10	10	μА	VIN = 0 to 5.5V
ILO	Output Leakage Current	-10	10	μА	VOUT = 0 to 5.5V
ICC3	VCC Power-Down Current		100	μА	CE = VCC ± 0.3V
ICC2	VCC Standby Current		1.5	mA	CE = VIH
ICC1	VCC Active Current	- '- '-	60	mA	CE = VIL, f=5MHz, lout = 0mA
IPP	VPP Supply Current Read		100	μА	CE = OE = VIL, VPP = 5.5V

# CAPACITANCE TA = 25°C, f = 1.0 MHz (Sampled only)

SYMBOL	PARAMETER	TYP.	MAX.	UNIT	CONDITIONS
CIN	Input Capacitance	8	12	pF	VIN = 0V
COUT	Output Capacitance	8	12	pF	VOUT = 0V
CVPP	VPP Capacitance	18	25	pF	VPP = 0V

# AC CHARACTERISTICS TA = 0°C to 70°C, VCC = $5V\pm 10\%$

		27C8	100-12	27C8	100-15	27C8	100-17	27C8	100-20		***
SYMBOL	PARAMETER	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	UNIT	CONDITIONS
tACC	Address to Output Delay		120		150		175		200	ns	CE = OE = VIL
tCE	Chip Enable to Output Delay		120		150		175		200	ns	OE = VIL
tOE	Output Enable to Output Delay		50		65		70		80	ns	CE = VIL
tDF	OE High to Output Float, or CE High to Output Float0	0	35	0	50	0	50	0	50	ns	
tOH	Output Hold from Address,	0		0	•	0		0		ns	
	CE or OE which ever occurred first										



# **AC CHARACTERISTICS(Continued)**

		27C8100-12 27C8100-		27C8100-15	27C8100-17	27C8100-20	00-20	
SYMBOL	PARAMETER	MIN.	MAX.	MIN. MAX.	MIN. MAX.	MIN. MAX.	UNIT	CONDITIONS
tBHA	BYTE Access Time		120	150	175	200	ns .	
tOHB	BYTE Output Hold Time	O		0	0	0	ns	
tBHZ	BYTE Output Delay Time	,	70	70	70	70	ns	
tBLZ	BYTE Output Set Time	10		10	10	10	ns	

# DC PROGRAMMING CHARACTERISTICS TA = 25°C ± 5°C

SYMBOL	PARAMETER	MIN.	MAX.	UNIT	CONDITIONS
VOH	Output High Voltage	2.4		٧ .	IOH = -0.40mA
VOL	Output Low Voltage		0.4	٧	IOL = 2.1mA
VIH	Input High Voltage	2.0	VCC + 0.5	٧	
VIL	Input Low Voltage	-0.3	0.8	٧	
ILI	Input Leakage Current	-10	10	μА	VIN = 0 to 5.5V
VH	A9 Auto Select Voltage	11.5	12.5	٧	
ICC3	VCC Supply Current (Program & Verify)		50	mA	
IPP2	VPP Supply Current(Program)		30	mA	CE = VIL, OE = VIH
VCC1	Interactive Supply Voltage	5.75	6.25	Ń.	
VPP1	Interactive Programming Voltage	12.0	13.0	٧	
VCC2	Fast Programming Supply Voltage	6.00	6.50	٧	
VPP2	Fast Programming Voltage	12.5	13.0	٧	

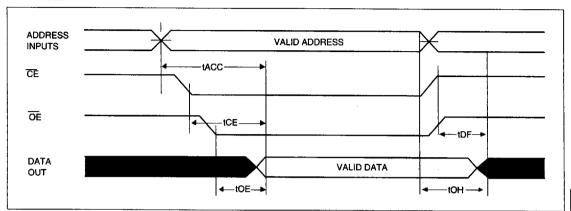
## AC PROGRAMMING CHARACTERISTICS TA = $25^{\circ}$ C $\pm 5^{\circ}$ C

SYMBOL	PARAMETER		MIN.	MAX.	UNIT	CONDITIONS
tAS	Address Setup Time		2.0		μЅ	
tOES	OE Setup Time		2.0		μS	
tDS	Data Setup Time		2.0		μS	
tAH	Address Hold Time		0		μS	
tDH	Data Hold Time		2.0		μS	
tDFP	CE to Output Float Delay		0	130	nS	
tVPS	VPP Setup Time		2.0		μS	
tPW	CE Program Pulse Width	Fast	95	105	μS	
		Interactive	0.95	1.05	mS	
tOPW	CE Overprogram Pulse(Intera	active)	1.95	2.05	mS	
tVCS	VCC Setup Time		2.0		μS	
tDV	Data Valid from CE			250	nS	
tCES	CE Setup Time		2.0		μS	
tOE	Data valid from OE			150	nS	



## **WAVEFORMS**

READ CYCLE

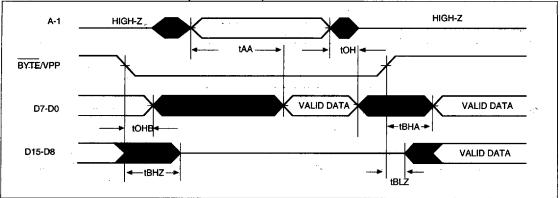




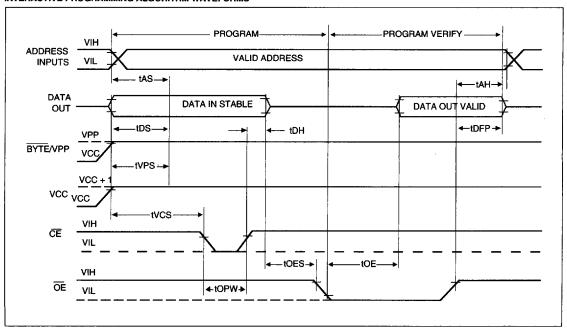


## **WAVEFORMS**





### INTERACTIVE PROGRAMMING ALGORITHM WAVEFORMS





## **ORDERING INFORMATION**

**CERAMIC PACKAGE** 

PART NO.	ACCESS TIME	OPERATING CURRENT	STANDBY CURRENT	PACKAGE
	(ns)	MAX.(mA)	MAX.(μA)	
MX27C8100DC-12	120	60	100	42 Pin DIP(ROM pin out)
MX27C8100DC-15	150	60	100	42 Pin DIP(ROM pin out
MX27C8100DC-17	175	60	100	42 Pin DIP(ROM pin out)
MX27C8100DC-20	200	60	100	42 Pin DIP(ROM pin out)

PLASTIC PACKAGE

PART NO.	ACCESS TIME (ns)	OPERATING CURRENT MAX.(mA)	STANDBY CURRENT MAX.(µA)	PACKAGE
MX27C8100PC-15	150	60	100	42 Pin DIP(ROM pin out)
MX27C8100PC-17	175	60	100	42 Pin DIP(ROM pin out)
MX27C8100PC-20	200	60	100	42 Pin DIP(ROM pin out)
MX27C8100MC-12	120	60	100	44 Pin SOP(ROM pin out)
MX27C8100MC-15	150	60	100	44 Pin SOP(ROM pin out)
MX27C8100MC-12	175	60	100	44 Pin SOP(ROM pin out)
MX27C8100MC-15	200	60	100	44 Pin SOP(ROM pin out)